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Application/Control No.	Applicant(s)/Patent under Reexamination
10/521,347	MULLER ET AL.
Examiner	Art Unit

PHILIPPE S. DERAKSHANI

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SEARCHED				
Class	Subclass	Date	Examiner	
222	137 145.6	4/5/2007	PD	
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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